

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/522,107	BIRKWALD ET AL.		
Examiner	Art Unit		
Faye M. Fleming	3616		

SEARCHED				
	JLAN			
Class	Subclass	Date	Examiner	
280	86.75 86.752	9/25/2007	FF	
280	124.152	9/25/2007	FF	
280	124.154	9/25/2007	FF	
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INTERFERENCE SEARCHED				
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